

Device Modeling Report

COMPONENTS: BIPOLAR JUNCTION TRANSISTOR
PART NUMBER: 2SC2547
MANUFACTURER: RENESAS

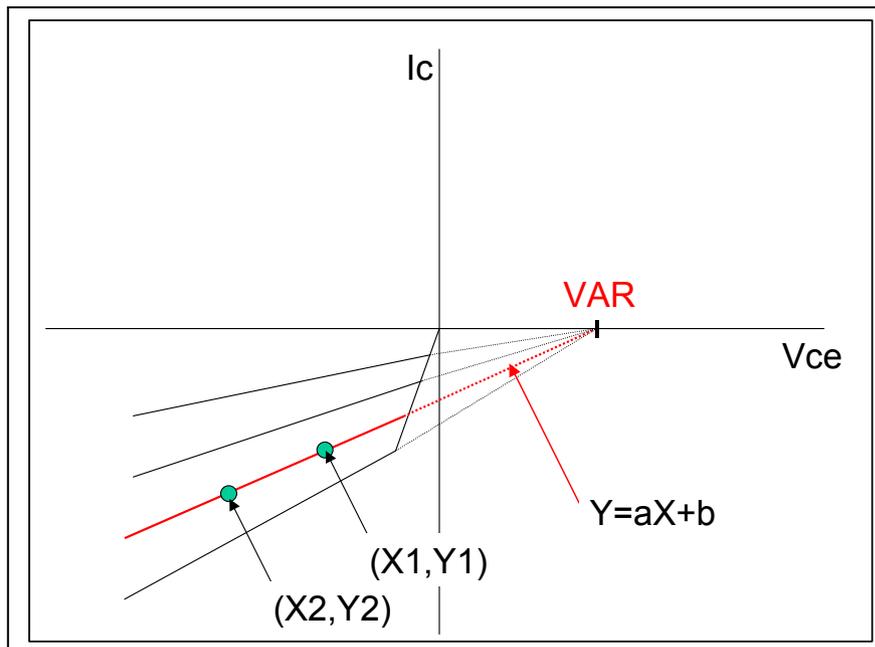
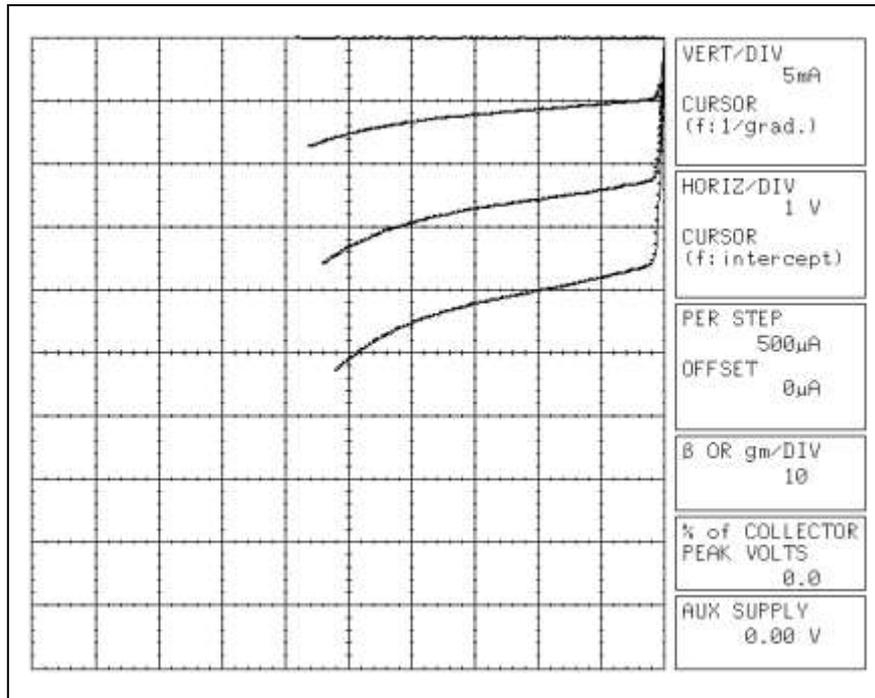


Bee Technologies Inc.

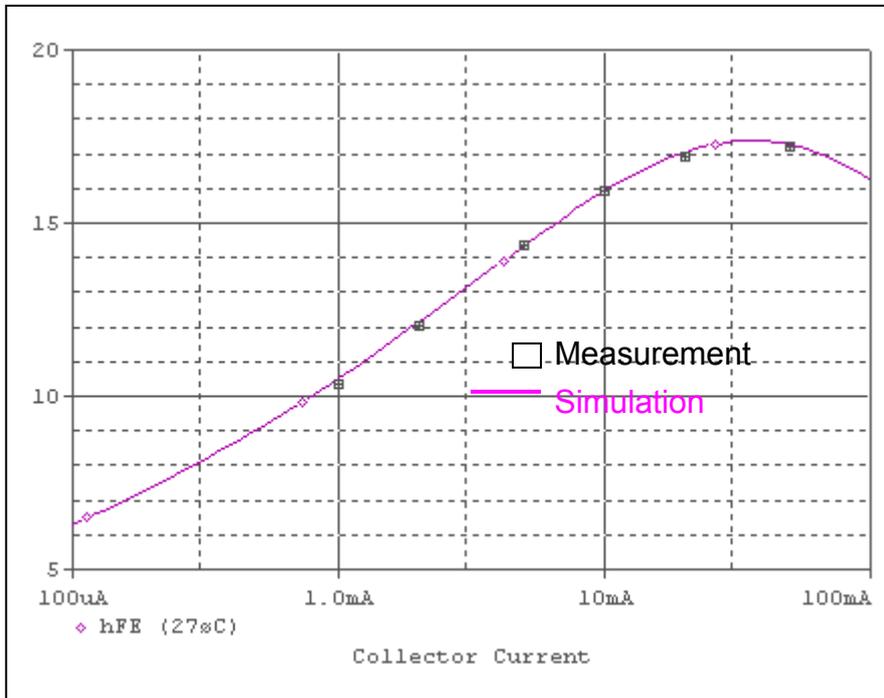
| Pspice model parameter | Model description |
|------------------------|-------------------------------------------------------------|
| IS | Saturation Current |
| BF | Ideal Maximum Forward Beta |
| NF | Forward Current Emission Coefficient |
| VAF | Forward Early Voltage |
| IKF | Forward Beta Roll-off Knee Current |
| ISE | Non-ideal Base-Emitter Diode Saturation Current |
| NE | Non-ideal Base-Emitter Diode Emission Coefficient |
| BR | Ideal Maximum Reverse Beta |
| NR | Reverse Emission Coefficient |
| VAR | Reverse Early Voltage |
| IKR | Reverse Beta Roll-off Knee Current |
| ISC | Non-ideal Base-Collector Diode Saturation Current |
| NC | Non-ideal Base-Collector Diode Emission Coefficient |
| NK | Forward Beta Roll-off Slope Exponent |
| RE | Emitter Resistance |
| RB | Base Resistance |
| RC | Series Collector Resistance |
| CJE | Zero-bias Emitter-Base Junction Capacitance |
| VJE | Emitter-Base Junction Potential |
| MJE | Emitter-Base Junction Grading Coefficient |
| CJC | Zero-bias Collector-Base Junction Capacitance |
| VJC | Collector-base Junction Potential |
| MJC | Collector-base Junction Grading Coefficient |
| FC | Coefficient for Onset of Forward-bias Depletion Capacitance |
| TF | Forward Transit Time |
| XTF | Coefficient for TF Dependency on Vce |
| VTF | Voltage for TF Dependency on Vce |
| ITF | Current for TF Dependency on Ic |
| PTF | Excess Phase at $f=1/2\pi*TF$ |
| TR | Reverse Transit Time |
| EG | Activation Energy |
| XTB | Forward Beta Temperature Coefficient |
| XTI | Temperature Coefficient for IS |

Reverse

Reverse Early Voltage Characteristic

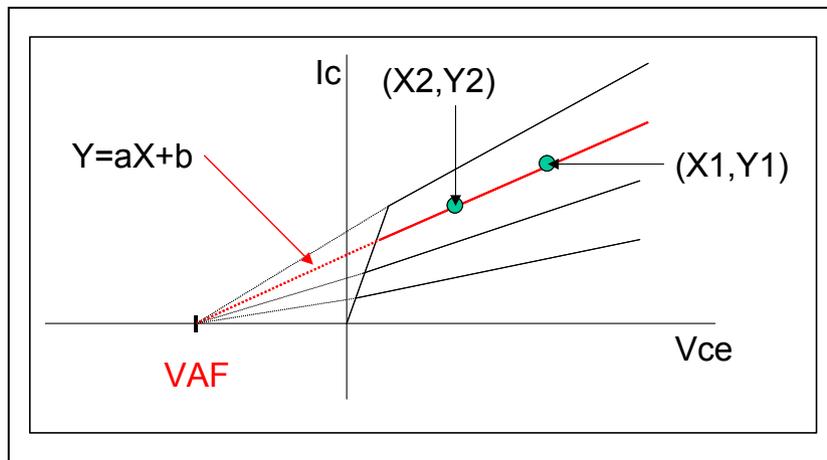
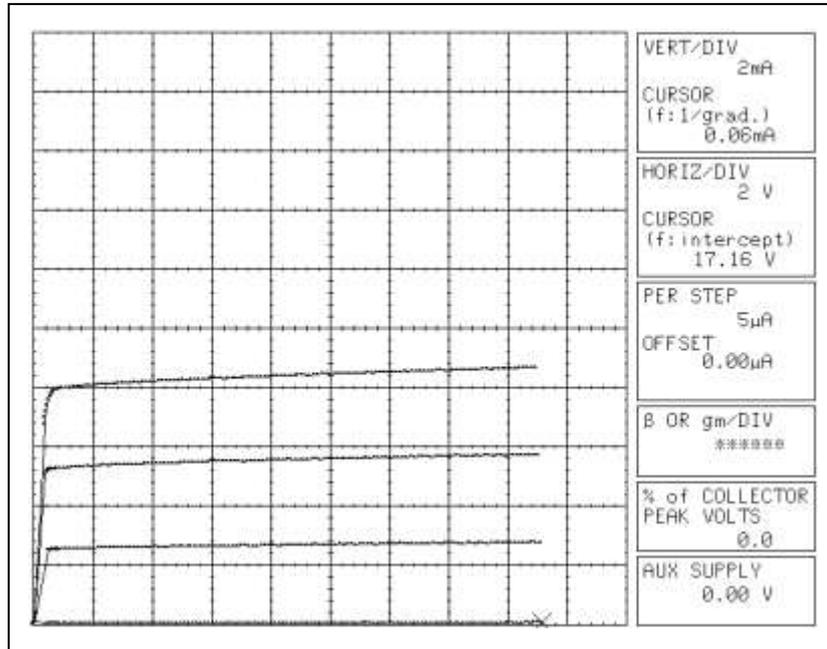


Reverse DC Beta Characteristic (Ie vs. hFE)

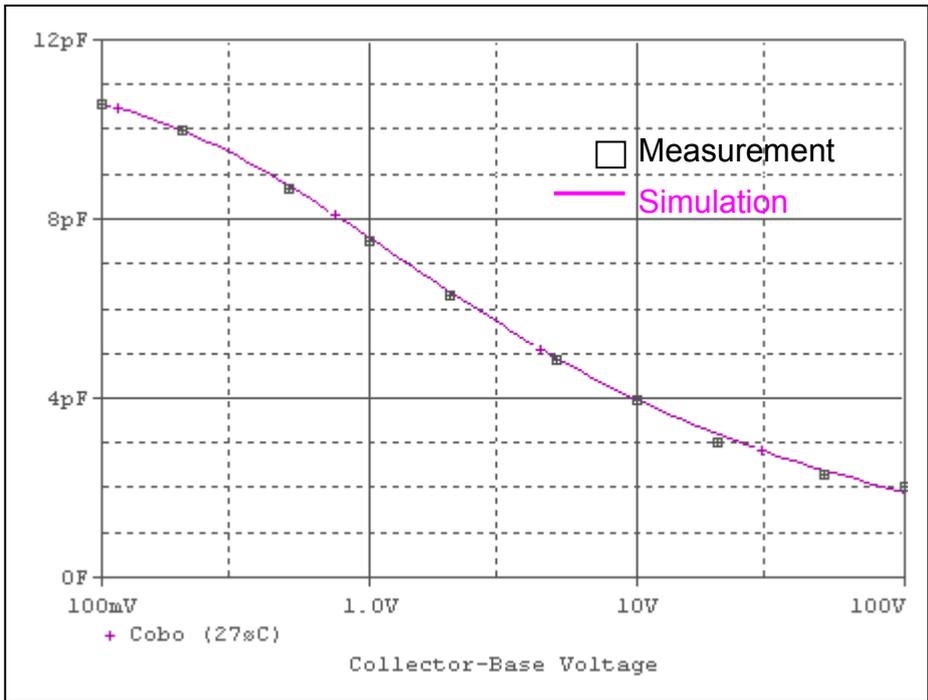


Forward

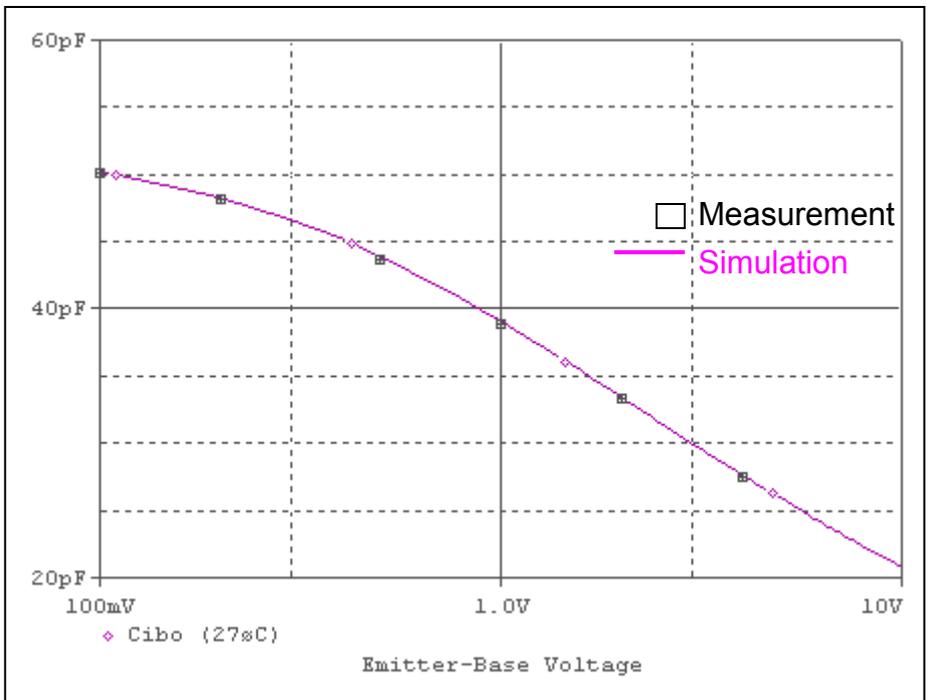
Forward Early Voltage Characteristic



C-B Capacitance Characteristic

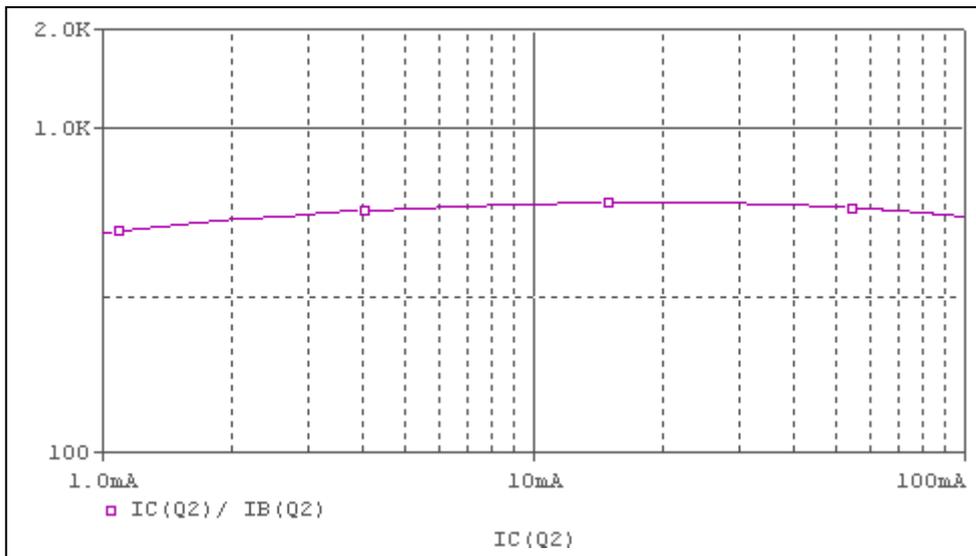


E-B Capacitance Characteristic

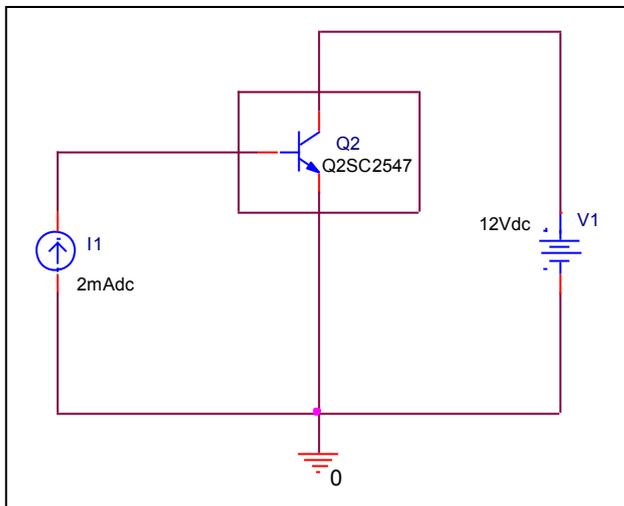


BJT Ic-hFE characteristics

Circuit simulation result

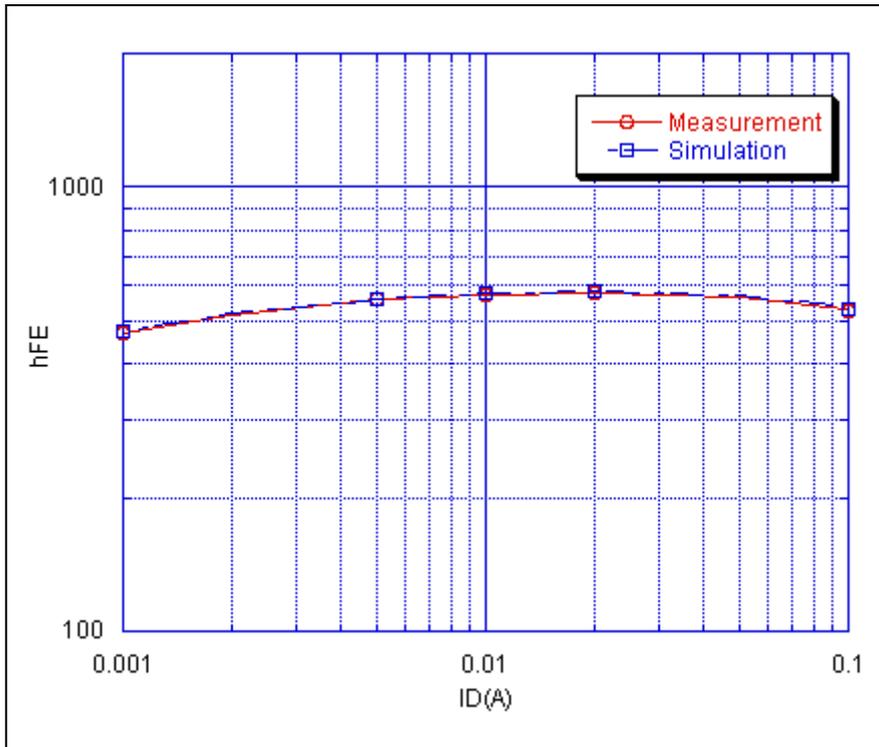


Evaluation circuit



Comparison Graph

Circuit simulation result

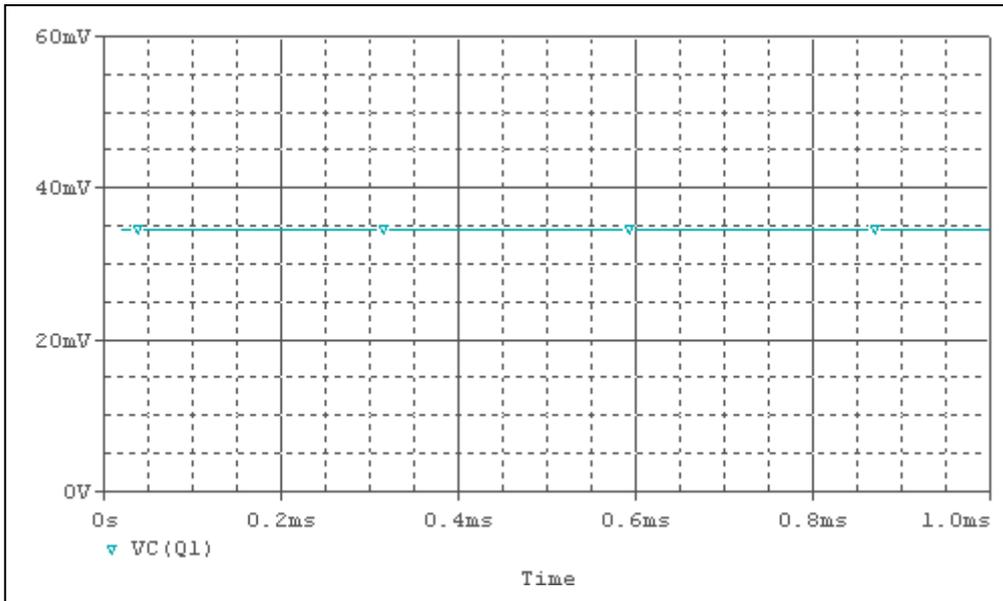


Simulation result

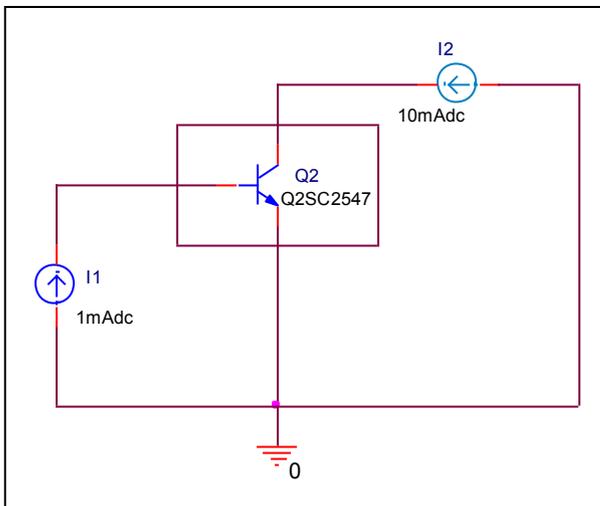
| I_c (A) | hFE | | %Error |
|-----------|-------------|------------|-------------|
| | Measurement | Simulation | |
| 0.001 | 468.78 | 475.3 | 1.390844319 |
| 0.002 | 517.54 | 518.537 | 0.192642115 |
| 0.005 | 559.8 | 560.596 | 0.142193641 |
| 0.01 | 571.43 | 579.803 | 1.465271337 |
| 0.02 | 576.07 | 586.4 | 1.793184856 |
| 0.05 | 566.89 | 569.07 | 0.384554323 |
| 0.1 | 523.56 | 530.56 | 1.337000535 |

BJT Vce(sat) voltage Characteristics

Circuit simulation result



Evaluation circuit



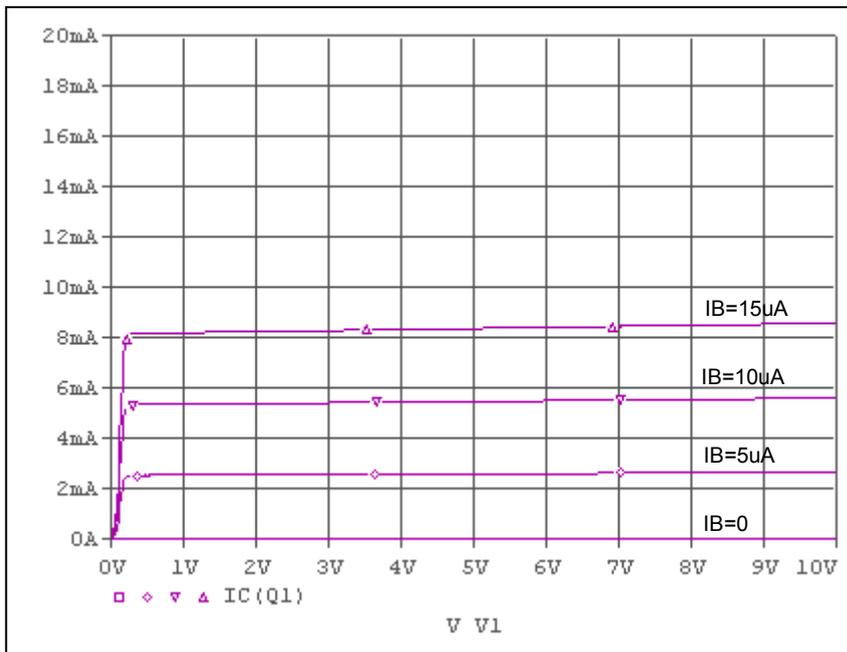
Simulation result

Test condition: $I_C/I_B = 10$, $I_C=100\text{mA}$

| Vce(sat)(V) | | |
|-------------|------------|----------|
| Measurement | Simulation | Error(%) |
| 200m[max] | 34.6m | - |

Output Characteristics

Circuit simulation result



Evaluation circuit

